

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ONISHI ET AL.	
		Examiner Ives Wu	Art Unit 1724	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,954,557	09-1990	Iwanami et al.	524/399
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP-1043361-A1	11-2000	Japan	Onishi et al	C08L 29/04
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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